



SPICE Device Model Si5945DU

Vishay Siliconix

Dual P-Channel 20-V (D-S) MOSFET

CHARACTERISTICS

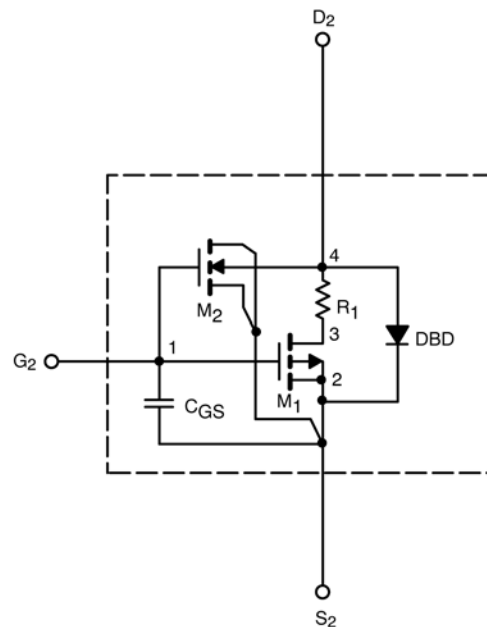
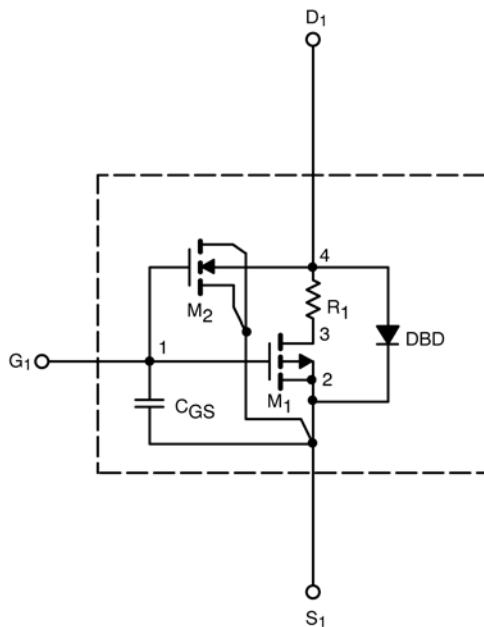
- P-Channel Vertical DMOS
- Macro Model (Subcircuit Model)
- Level 3 MOS
- Apply for both Linear and Switching Application
- Accurate over the -55 to 125°C Temperature Range
- Model the Gate Charge, Transient, and Diode Reverse Recovery Characteristics

DESCRIPTION

The attached spice model describes the typical electrical characteristics of the p-channel vertical DMOS. The subcircuit model is extracted and optimized over the -55 to 125°C temperature ranges under the pulsed 0-V to 5-V gate drive. The saturated output impedance is best fit at the gate bias near the threshold voltage.

A novel gate-to-drain feedback capacitance network is used to model the gate charge characteristics while avoiding convergence difficulties of the switched C_{gd} model. All model parameter values are optimized to provide a best fit to the measured electrical data and are not intended as an exact physical interpretation of the device.

SUBCIRCUIT MODEL SCHEMATIC



This document is intended as a SPICE modeling guideline and does not constitute a commercial product data sheet. Designers should refer to the appropriate data sheet of the same number for guaranteed specification limits.

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SPECIFICATIONS ($T_J = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)					
Parameter	Symbol	Test Condition	Simulated Data	Measured Data	Unit
Static					
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$	0.80		V
On-State Drain Current ^a	$I_{D(on)}$	$V_{DS} \leq -5\text{V}, V_{GS} = -4.5\text{V}$	60		A
Drain-Source On-State Resistance ^a	$r_{DS(on)}$	$V_{GS} = -4.5\text{V}, I_D = -3.3\text{A}$	0.063	0.060	Ω
		$V_{GS} = -2.5\text{V}, I_D = -2.8\text{A}$	0.082	0.083	
		$V_{GS} = -1.8\text{V}, I_D = -0.76\text{A}$	0.107	0.108	
Forward Transconductance ^a	g_{fs}	$V_{DS} = -10\text{V}, I_D = -3.3\text{A}$	11	9	S
Diode Forward Voltage ^a	V_{SD}	$I_S = -1\text{A}, V_{GS} = 0\text{V}$	-0.78	-0.80	V
Dynamic^b					
Input Capacitance	C_{iss}	$V_{DS} = -10\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$	589	455	pF
Output Capacitance	C_{oss}		103	105	
Reverse Transfer Capacitance	C_{rss}		57	65	
Total Gate Charge	Q_g	$V_{DS} = -10\text{V}, V_{GS} = -8\text{V}, I_D = -4.6\text{A}$	8.4	9.1	nC
Gate-Source Charge	Q_{gs}	$V_{DS} = -10\text{V}, V_{GS} = -4.5\text{V}, I_D = -4.6\text{A}$	5	5.5	
Gate-Drain Charge	Q_{gd}		0.75	0.75	
			1.5	1.5	

Notes

a. Pulse test; pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.

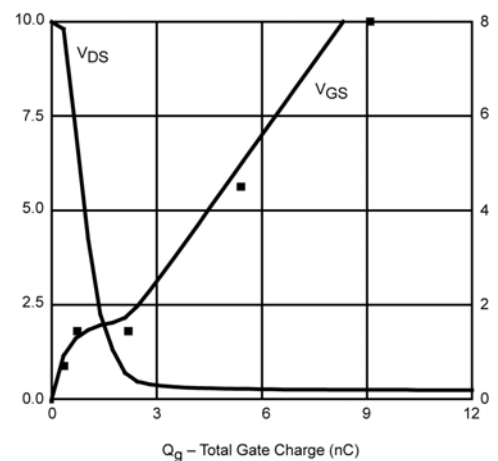
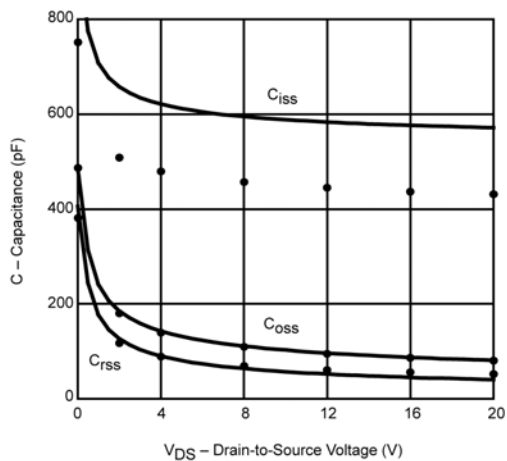
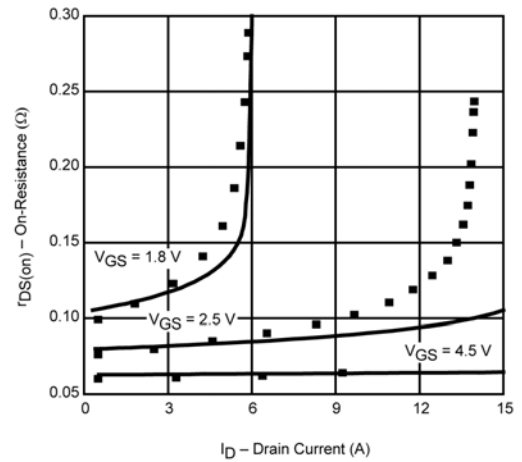
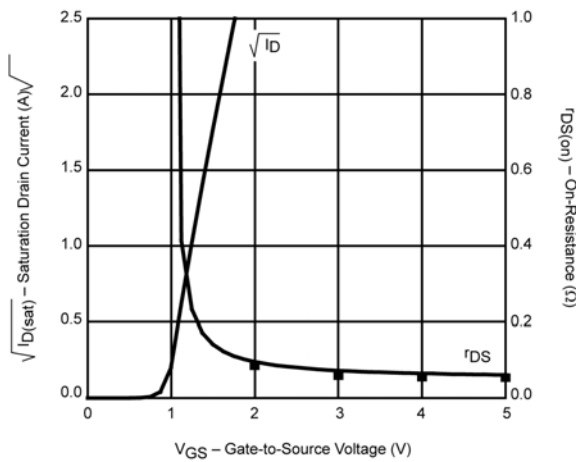
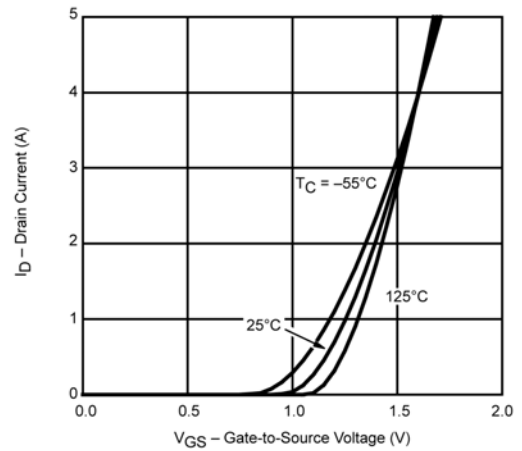
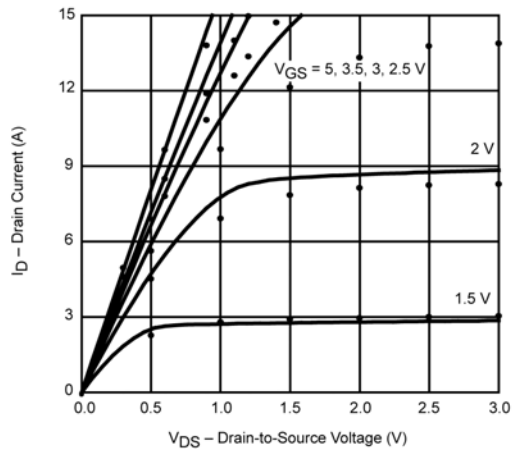
b. Guaranteed by design, not subject to production testing.



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COMPARISON OF MODEL WITH MEASURED DATA ($T_J=25^\circ\text{C}$ UNLESS OTHERWISE NOTED)



Note: Dots and squares represent measured data.